

<b>Notice of References Cited</b>	Application/Control No. 08/796,519	Applicant(s)/Patent Under Reexamination INOUE ET AL.	
	Examiner LAM S. NGUYEN	Art Unit 2853	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,552,816	09-1996	Oda et al.	347/86
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N	EP 546 832 A2	06-1993	EP	Wada et al.	--/--
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	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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